

Maximum Ratings (@ $T_A = +25$ °C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Drain-Source Voltage		V_{DSS}	60	V
Gate-Source Voltage		Vgss	±20	V
Continuous Preis Correct (Note 5) V 40V	T _A = +25°C T _A = +70°C	I _D	13 11	А
Continuous Drain Current (Note 5) V _{GS} = 10V	$T_C = +25$ °C $T_C = +70$ °C	lo	30 24	А
Maximum Continuous Body Diode Forward Current (Note 5)	ls	3	Α	
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)		I _{DM}	80	Α
Avalanche Current, L=0.1mH		las	20	А
Avalanche Energy, L=0.1mH		Eas	20	mJ

Thermal Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit	
Total Bower Dissipation (Note 5)	$T_A = +25$ °C	PD	2.2	W	
Total Power Dissipation (Note 5)	$T_C = +25^{\circ}C$	PD	41		
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	Р	55		
Thermal Resistance, Junction to Ambient (Note 3)	t<10s	$R_{\theta JA}$	35	°C/W	
Thermal Resistance, Junction to Case (Note 5)		Rejc	3		
Operating and Storage Temperature Range		TJ, TSTG	-55 to +150	°C	

Electrical Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 6)						
Drain-Source Breakdown Voltage	BV _{DSS}	60	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	IDSS	_	_	1	μΑ	V _{DS} = 48V, V _{GS} = 0V
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 6)						
Gate Threshold Voltage	Vgs(th)	0.8	_	2	V	V _{DS} = V _{GS} , I _D = 250µA
Static Drain-Source On-Resistance	Process	_	6	7.5	mΩ	$V_{GS} = 10V, I_{D} = 20A$
Static Dialii-Source Off-Resistance	RDS(ON)	_	7.8	11.5		$V_{GS} = 4.5V, I_{D} = 20A$
Diode Forward Voltage	V _{SD}	_	0.9	1.2	V	$V_{GS} = 0V, I_{S} = 20A$
DYNAMIC CHARACTERISTICS (Note 7)						
Input Capacitance	Ciss		2,090	_		V _{DS} = 30V, V _{GS} = 0V, f = 1.0MHz
Output Capacitance	Coss	_	746	_	pF	
Reverse Transfer Capacitance	Crss	_	38.5	_		
Gate Resistance	Rg	_	0.59	_	Ω	$V_{DS} = 0V, V_{GS} = 0V,$ f = 1.0MHz
Total Gate Charge (VGS = 4.5V)	Q _G	_	19.3	_		
Total Gate Charge (V _{GS} = 10V)	Q_G	_	41.3	_	nC	V _{DS} = 30V, I _D = 20A
Gate-Source Charge	Qgs	_	6.0	_	nc nc	
Gate-Drain Charge	Q_{GD}	_	8.8	_		
Turn-On Delay Time	td(on)	_	5.7	_		
Turn-On Rise Time	t _R	_	4.3	_	ns	$V_{DD} = 30V, V_{GS} = 10V,$
Turn-Off Delay Time	tD(OFF)	_	23.4	_	115	$I_D = 20A$, $R_G = 3\Omega$
Turn-Off Fall Time	tF	_	9.7	_		

Notes:

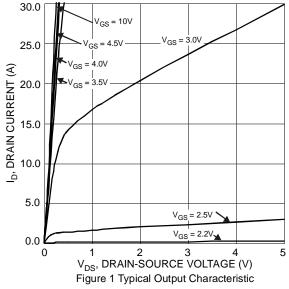
^{5.} ReJA is determined with the device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate. ReJC is guaranteed by design while ReJA is determined by the user's board design.

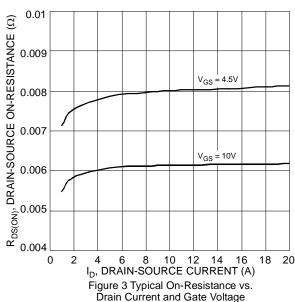
^{6.} Short duration pulse test used to minimize self-heating effect.

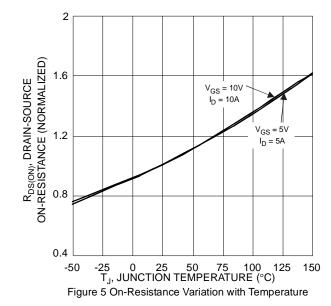
^{7.} Guaranteed by design. Not subject to product testing.

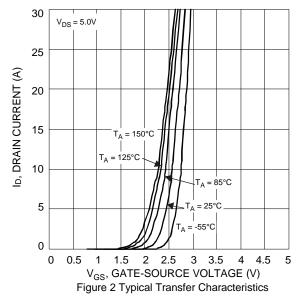


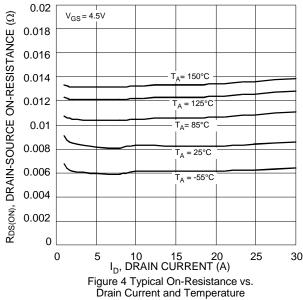


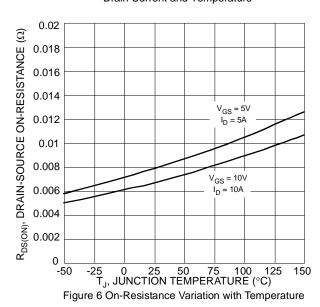














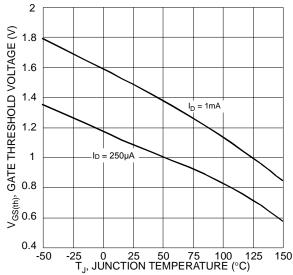
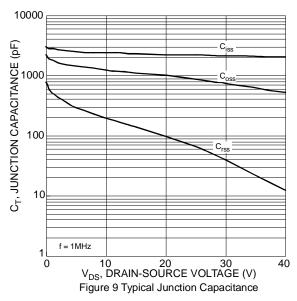
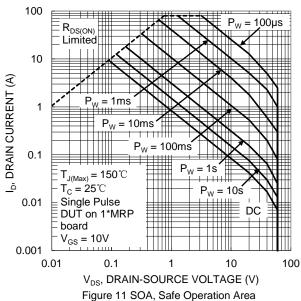
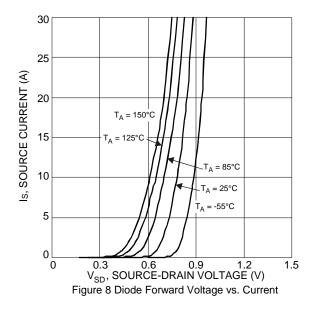
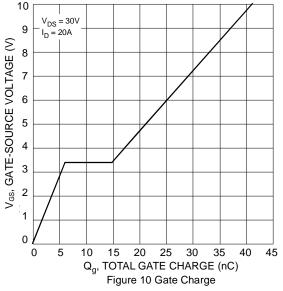


Figure 7 Gate Threshold Variation vs. Junction Temperature











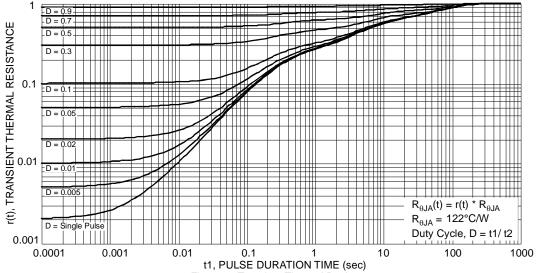


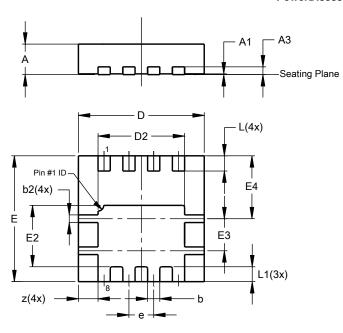
Figure 12 Transient Thermal Resistance



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

PowerDI3333-8

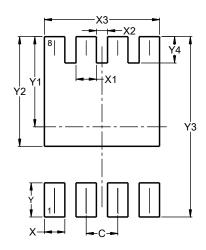


PowerDI3333-8					
Dim	Min	Max	Тур		
Α	0.75	0.85	0.80		
A1	0.00	0.05	0.02		
A3	_	_	0.203		
b	0.27	0.37	0.32		
b2	0.15	0.25	0.20		
D	3.25	3.35	3.30		
D2	2.22	2.32	2.27		
Е	3.25	3.35	3.30		
E2	1.56	1.66	1.61		
E3	0.79	0.89	0.84		
E4	1.60	1.70	1.65		
е	1	-	0.65		
L	0.35	0.45	0.40		
L1	_	_	0.39		
Z	_	_	0.515		
All Dimensions in mm					

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

PowerDI3333-8



Dimensions	Value (in mm)
С	0.650
Х	0.420
X1	0.420
X2	0.230
Х3	2.370
Υ	0.700
Y1	1.850
Y2	2.250
Y3	3.700
Y4	0.540



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7 of 7

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